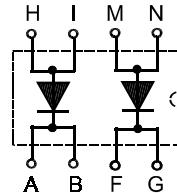


Fast Recovery Epitaxial Diode (FRED)

DSEI 2x61

I_{FAVM} = 2x60 A
V_{RRM} = 600 V
t_{rr} = 35 ns

V _{RSM}	V _{RRM}	Type
V	V	
600	600	DSEI 2x 61-06P



Symbol	Conditions	Maximum Ratings (per diode)		
I _{FRMS}	T _{VJ} = T _{VJM}	100	A	
I _{FAVM} ①	T _C = 70°C; rectangular; d = 0.5	60	A	
I _{FRM}	t _p < 10 µs; rep. rating; pulse width limited by T _{VJM}	800	A	
I _{FSM}	T _{VJ} = 45°C; t = 10 ms (50 Hz), sine	550	A	
T _{VJ}		-40...+150	°C	
T _{VJM}		150	°C	
T _{stg}		-40...+150	°C	
P _{tot}	T _C = 25°C	180	W	
V _{ISOL}	50/60 Hz, RMS	2500	V~	
	I _{ISOL} ≤ 1 mA	3000	V~	
M _d	Mounting torque (M4)	1.5 - 2.0 14 - 18	Nm lb.in.	
Weight		18	g	

Symbol	Conditions	Characteristic Values (per diode)		
		typ.	max.	
I _R	T _{VJ} = 25°C V _R = V _{RRM} T _{VJ} = 25°C V _R = 0.8 • V _{RRM} T _{VJ} = 125°C V _R = 0.8 • V _{RRM}	200 100 14	µA µA mA	
V _F	I _F = 60 A; T _{VJ} = 150°C T _{VJ} = 25°C	1.5 1.8	V V	
V _{T0} r _T	For power-loss calculations only T _{VJ} = T _{VJM}	1.13 4.7	V mΩ	
R _{thJC} R _{thCK}		0.7 0.05	K/W K/W	
t _{rr}	I _F = 1 A; -di/dt = 200 A/µs V _R = 30 V; T _{VJ} = 25°C	35	50	ns
I _{RM}	V _R = 350 V; I _F = 60 A; -di _F /dt = 480 A/µs L ≤ 0.05 µH; T _{VJ} = 100°C	19	21	A
d _s d _A a	Creeping distance on surface Creeping distance in air Allowable acceleration	min. 11.2 min. 11.2 max. 50	mm mm m/s ²	

① I_{FAVM} rating includes reverse blocking losses at T_{VJM}, V_R = 0.8 V_{RRM}, duty cycle d = 0.5
Data according to IEC 60747

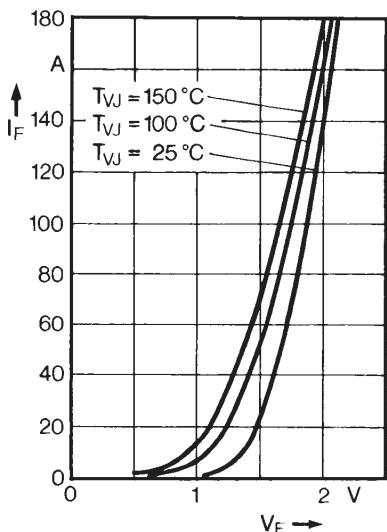


Fig. 1 Forward current versus voltage drop.

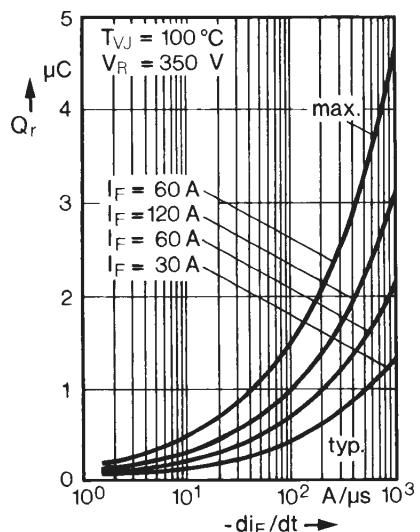


Fig. 2 Recovery charge versus $-di_F/dt$.

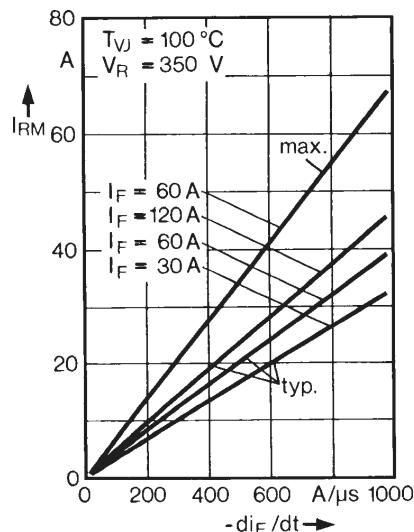


Fig. 3 Peak reverse current versus $-di_F/dt$.

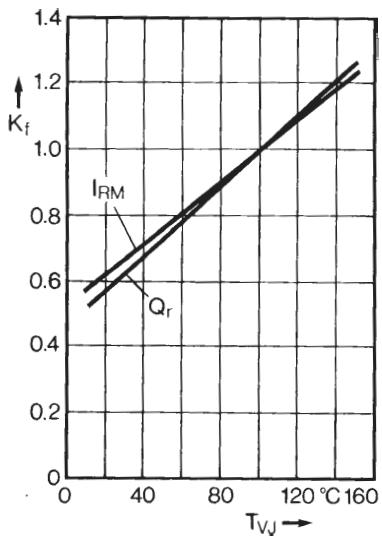


Fig. 4 Dynamic parameters versus junction temperature.

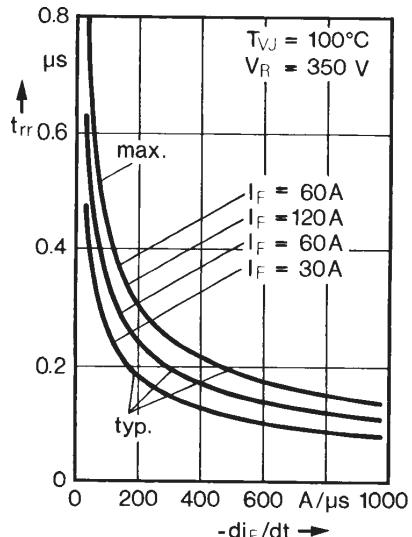


Fig. 5 Recovery time versus $-di_F/dt$.

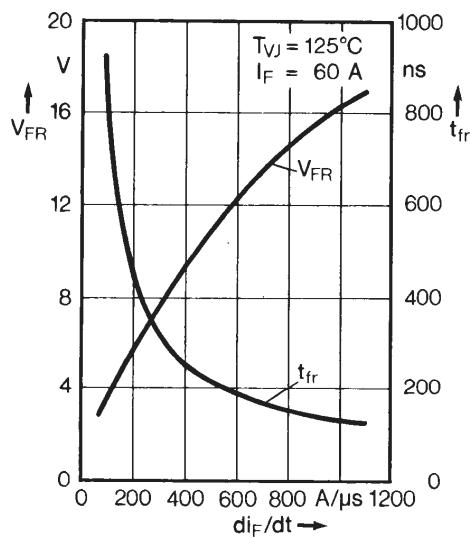


Fig. 6 Peak forward voltage versus di_F/dt .

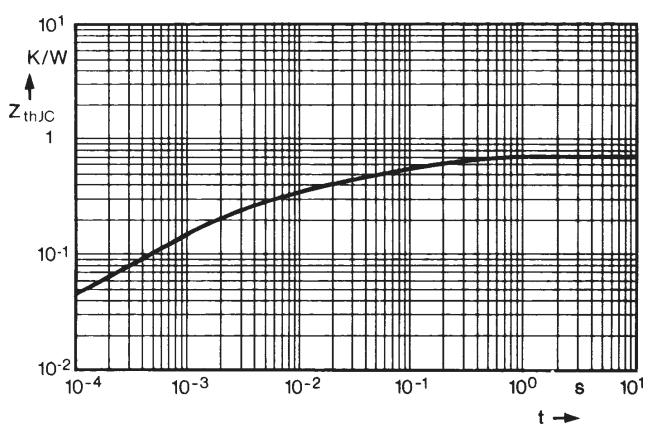


Fig. 7 Transient thermal impedance junction to case.

